

tion No.
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O.I.P.E. Inc.
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		DOCUMENT NUMBER								DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
/MD/	200	1	-	2	5	1	1	5	9	09/14/01	JAPAN				
↓	5	8	-	1	3	7	3	1	7	08/15/83	JAPAN				
	5	8	-	1	5	3	4	1	2	09/12/83	JAPAN				
	6	0	-	1	7	1	8	2	2	09/05/85	JAPAN				
			9	-	6	4	6	8	3	03/07/97	JAPAN				
	1	0	-	2	0	0	3	5	4	07/31/98	JAPAN				

/MD/	1	English language Abstract of JP 2001-251159.
↓	2	English language Abstract of JP 58-137317. No Date Available
	3	English language Abstract of JP 58-153412. No Date Available
	4	English language Abstract of JP 60-171822. No Date Available
	5	English language Abstract of JP 9-64683. No Date Available
	6	English language Abstract of JP 10-200354. No Date Available

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10/811,812

(Use several sheets if necessary)

Applicant
Eiji KOMURO et al.

Filing Date
March 30, 2004

**Group
2851**

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

[illegible]

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

/MD/	1	English language Abstract of JP 2001-77013.
/MD/	2	English language Abstract of JP 10-126160. No Date Available
/MD/	3	English language Abstract of JP 2002-335141.
/MD/	4	English language Abstract of JP 2002-344280.

EXAMINER /Mahmoud Dahimene/ (04/04/2007)

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